

TO SEPARATE, HOLD TOP AND BOTTOM EDGES, SNAP-APART AND DISCARD CARBON

FORM PTO-892
(REV. 2-92)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

SERIAL NO. *691434*
08/160909

GROUP PART UNIT
1107

ATTACHMENT
TO
PAPER
NUMBER

7

NOTICE OF REFERENCES CITED

APPLICANT(S)

Yamazaki et al.

U.S. PATENT DOCUMENTS

	DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
A	<i>5194398</i>	<i>3/1993</i>	<i>Miyachi et al.</i>	<i>437</i>	<i>101</i>	<i>6/1990</i>
B	<i>4888305</i>	<i>12/1989</i>	<i>Yamazaki et al.</i>	<i>437</i>	<i>101</i>	
C	<i>5310410</i>	<i>5/1994</i>	<i>Begin et al.</i>	<i>118</i>	<i>719</i>	<i>4/1990</i>
D	<i>5200017</i>	<i>4/1993</i>	<i>Kawasaki et al.</i>	<i>118</i>	<i>719</i>	<i>2/1990</i>
E	<i>4937205</i>	<i>6/1990</i>	<i>Nakayama et al.</i>	<i>437</i>	<i>165</i>	
F	<i>5292675</i>	<i>3/1994</i>	<i>Codomo</i>	<i>437</i>	<i>21</i>	<i>12/1992</i>
G	<i>4663829</i>	<i>5/1987</i>	<i>Hartman et al.</i>	<i>437</i>	<i>101</i>	
H	<i>5186718</i>	<i>2/1993</i>	<i>Tepman et al.</i>	<i>29</i>	<i>25.01</i>	
I	<i>5174881</i>	<i>12/1992</i>	<i>Iwasaki et al.</i>	<i>118</i>	<i>719</i>	
J	<i>5314538</i>	<i>5/1994</i>	<i>Maeda et al.</i>	<i>29</i>	<i>25.01</i>	
K	<i>5324360</i>	<i>6/1994</i>	<i>Kozuka</i>	<i>118</i>	<i>719</i>	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUB-CLASS	PERTINENT SHTS. DWG.	PP. SPEC.
L								
M								
N								
O								
P								
Q								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

Wilczewski

DATE

3/1995

1 of 2

* A copy of this reference is not being furnished with this office action.
(See Manual of Patent Examining Procedure, section 707.05 (a).)

FORM PTO-892 (REV. 2-92)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		SERIAL NO. <u>691431</u> <u>08/160909</u>		GROUP/ART UNIT <u>1107</u>		ATTACHMENT TO PAPER NUMBER <u>7</u>	
NOTICE OF REFERENCES CITED				APPLICANT(S) <u>Yamazaki et al.</u>					
U.S. PATENT DOCUMENTS									
*		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE		
	A	<u>4800174</u>	<u>1/1989</u>	<u>Ishihara et al.</u>	<u>437</u>	<u>101</u>			
	B	<u>5266116</u>	<u>11/1993</u>	<u>Fujioka et al.</u>	<u>118</u>	<u>719</u>			
	C	<u>5288658</u>	<u>2/1994</u>	<u>Ishihara</u>	<u>437</u>	<u>101</u>			
	D	<u>4988642</u>	<u>1/1991</u>	<u>Yamazaki</u>	<u>437</u>	<u>101</u>			
	E	<u>4808554</u>	<u>2/1989</u>	<u>Yamazaki</u>	<u>437</u>	<u>101</u>			
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